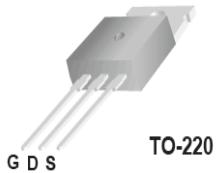


TSP60R280S1

600V 15A N-Channel SJ-MOSFET

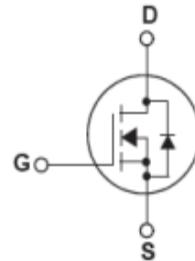
General Description

Truesemi SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance. This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.



Features

- 650V @ $T_J = 150\text{ }^{\circ}\text{C}$
- Typ. $R_{DS(on)} = 0.24\Omega$
- Ultra Low gate charge (typ. $Q_g = 43\text{nC}$)
- 100% avalanche tested



Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	600	V
I_D	Drain Current -Continuous ($TC = 25\text{ }^{\circ}\text{C}$)	15	A
	-Continuous ($TC = 100\text{ }^{\circ}\text{C}$)	9.4	
I_{DM}	Drain Current – Pulsed (Note 1)	45	A
V_{GSS}	Gate-Source voltage	± 30	V
E_{AS}	Single Pulsed Avalanche Energy (Note 2)	284	mJ
I_{AR}	Avalanche Current (Note 1)	2.4	A
E_{AR}	Repetitive Avalanche Energy (Note 1)	0.43	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	15	V/ns
P_D	Power Dissipation ($TC = 25\text{ }^{\circ}\text{C}$)	104	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^{\circ}\text{C}$
T_L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds	300	$^{\circ}\text{C}$

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.2	$^{\circ}\text{C}/\text{W}$
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics TC = 25°C unless otherwise noted

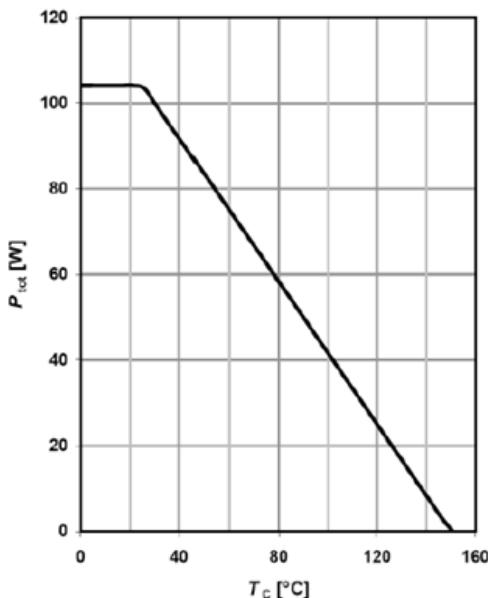
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A, T_J = 25^\circ C$	600	--	--	V
		$V_{GS} = 0V, I_D = 250\mu A, T_J = 150^\circ C$	--	650	--	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu A$, Referenced to $25^\circ C$	--	0.6	--	V/°C
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 600V, V_{GS} = 0V, -T_C = 150^\circ C$	--	-- 10	1	μA μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30V, V_{DS} = 0V$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30V, V_{DS} = 0V$	--	--	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.5	--	4.5	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10V, I_D = 7.5A$	--	0.24	0.28	Ω
g_{FS}	Forward Trans conductance	$V_{DS} = 40V, I_D = 15A$ (Note 4)	--	16	--	S
R_g	Gate resistance	f=1 MHz, open drain	--	3.5	--	Ω
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz$	--	800	--	pF
C_{oss}	Output Capacitance		--	340	--	pF
C_{rss}	Reverse Transfer Capacitance		--	10	--	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 400V, I_D = 7.5A$ $R_G = 20\Omega$ (Note 4, 5)	--	13	--	ns
t_r	Turn-On Rise Time		--	11	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	100	--	ns
t_f	Turn-Off Fall Time		--	12	--	ns
Q_g	Total Gate Charge	$V_{DS} = 480V, I_D = 7.5A$ $V_{GS} = 10V$ (Note 4, 5)	--	43	--	nC
Q_{gs}	Gate-Source Charge		--	5	--	nC
Q_{gd}	Gate-Drain Charge		--	22	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_s	Maximum Continuous Drain-Source Diode Forward Current	--	--	15	--	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	45	--	A
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0V, I_F = 7.5A$	--	0.9	1.5	V
t_{rr}	Reverse Recovery Time	$V_{GS} = 0V, I_F = 7.5A$ $di_F/dt = 100A/\mu s$ (Note 4)	--	345	--	ns
Q_{rr}	Reverse Recovery Charge		--	4.5	--	μC

NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. $I_{AS}=2.4A$, $V_{DD}=50V$, Starting $TJ=25^\circ C$
3. $I_{SD}\leq 15A$, $di/dt \leq 200A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting $TJ = 25^\circ C$
4. Pulse Test: Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$
5. Essentially Independent of Operating Temperature Typical Characteristics

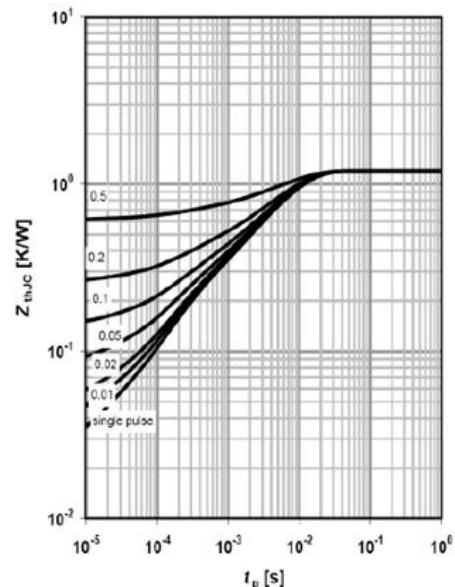
Typical Performance Characteristics

Power dissipation



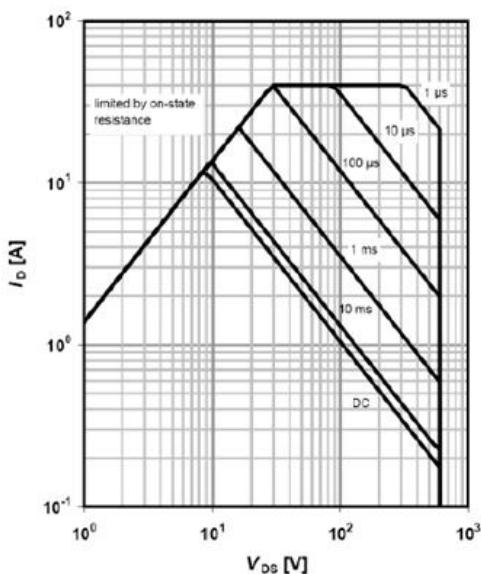
$$P_{tot} = f(T_C)$$

Max. transient thermal impedance



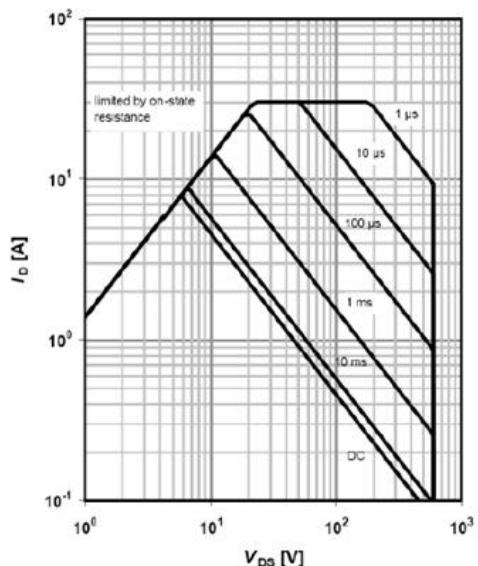
$$P_{tot} = f(T_C)$$

Safe operating area $T_C=25\text{ }^\circ\text{C}$



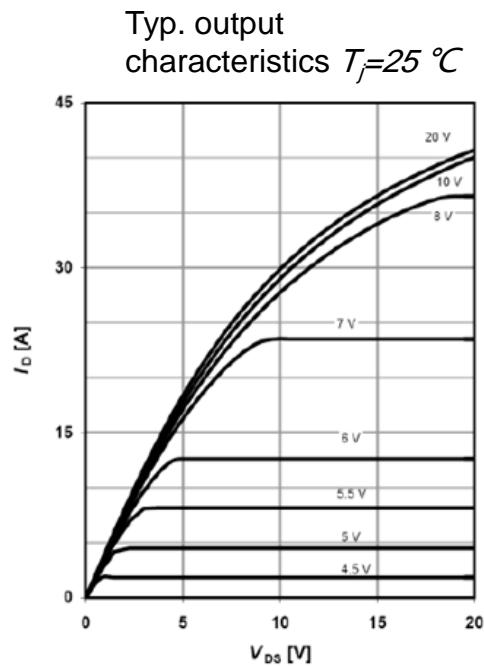
$$I_D = f(V_{DS}); T_C = 25\text{ }^\circ\text{C}; V_{GS} > 7\text{ V}; D=0; \text{parameter } t_p$$

Safe operating area $T_C=80\text{ }^\circ\text{C}$

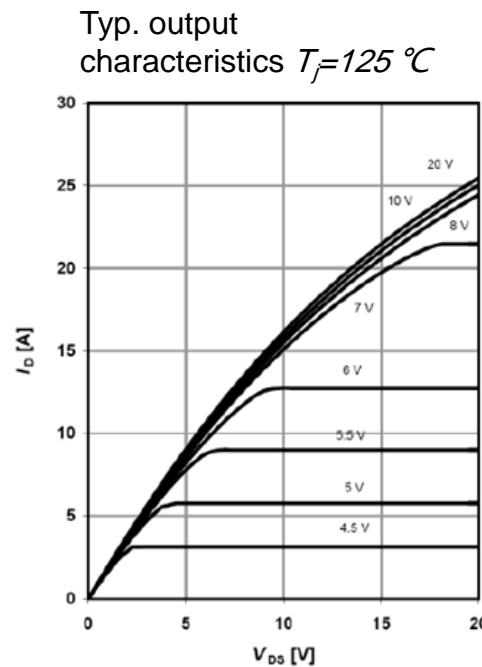


$$I_D = f(V_{DS}); T_C = 80\text{ }^\circ\text{C}; V_{GS} > 7\text{ V}; D=0; \text{parameter } t_p$$

Typical Performance Characteristics

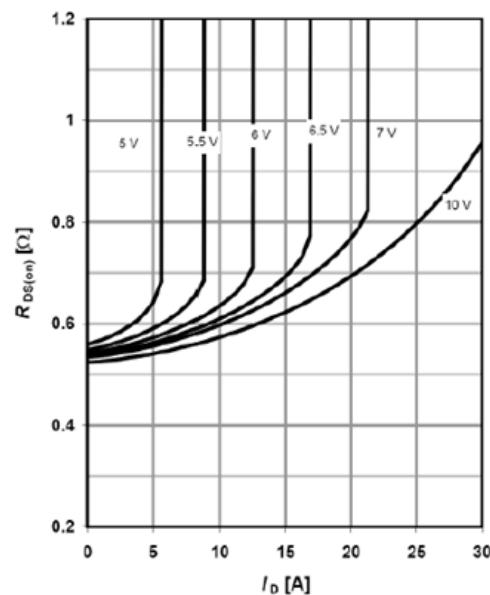


$I_D=f(V_{DS})$; $T_j=25\text{ }^{\circ}\text{C}$; parameter: V_{GS}



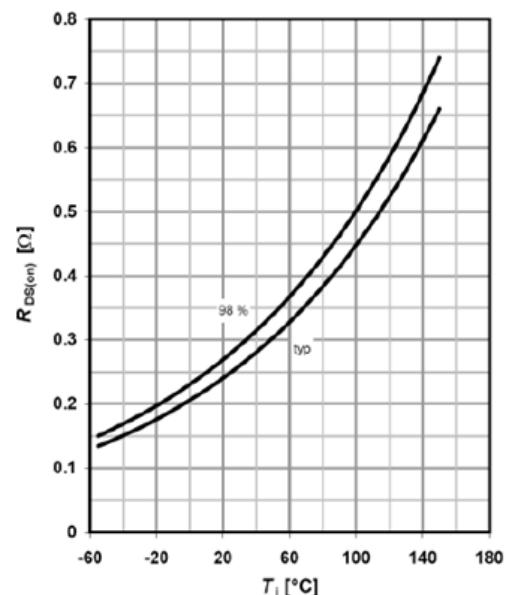
$I_D=f(V_{DS})$; $T_j=125\text{ }^{\circ}\text{C}$; parameter: V_{GS}

Typ. drain-source on-state resistance



$R_{DS(on)}=f(I_D)$; $T_j=125\text{ }^{\circ}\text{C}$;
parameter: V_{GS}

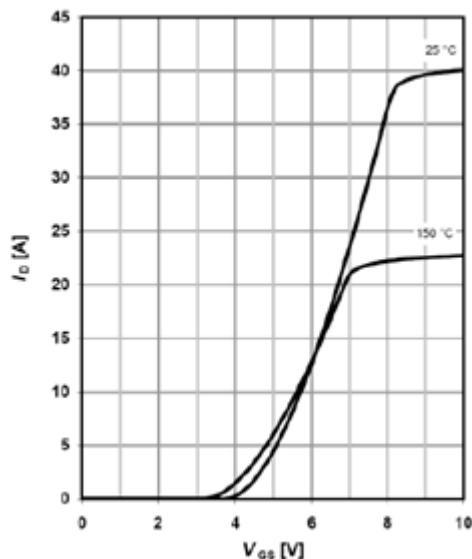
Typ. drain-source on-state resistance



$R_{DS(on)}=f(T_j)$; $I_D=6.5\text{ A}$; $V_{GS}=10\text{ V}$

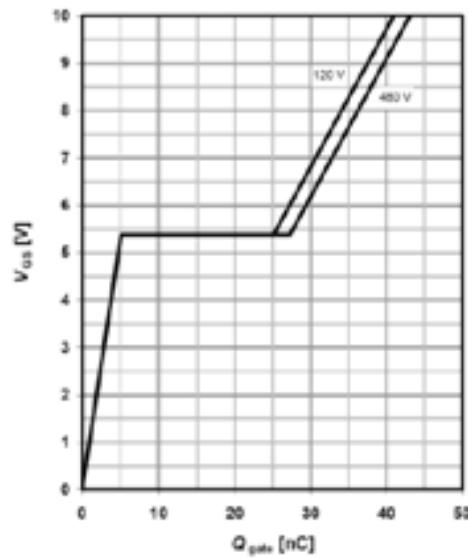
Typical Performance Characteristics

Typ. transfer characteristics



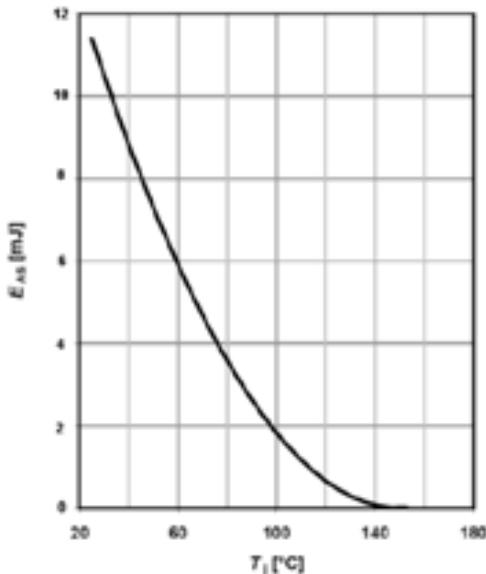
$$I_D = f(V_{GS}); V_{DS} = 20\text{ V}$$

Typ. gate charge



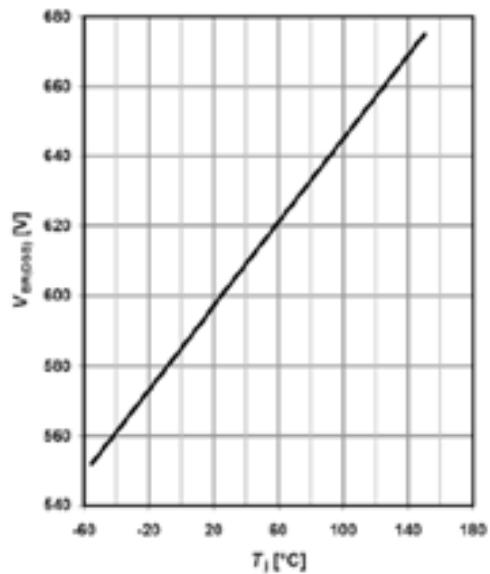
$$V_{GS} = f(Q_g), I_D = 6.5 \text{ A pulsed}$$

Avalanche energy



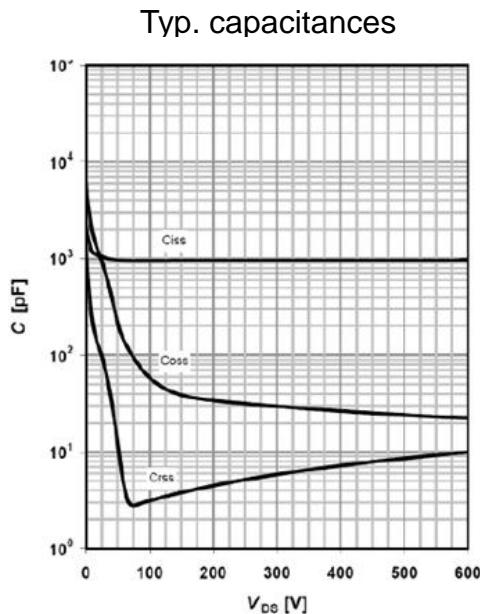
$$E_{AS} = f(T_j); I_D = 6.5 \text{ A}; V_{DD} = 50 \text{ V}$$

Drain-source breakdown voltage

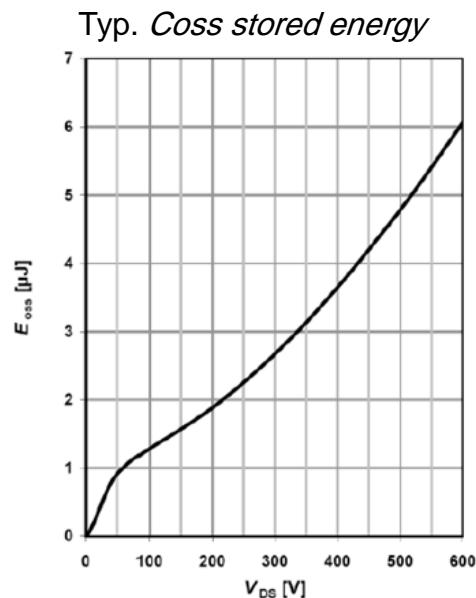


$$V_{BR(DSS)} = f(T_j); I_D = 0.25 \text{ mA}$$

Typical Performance Characteristics

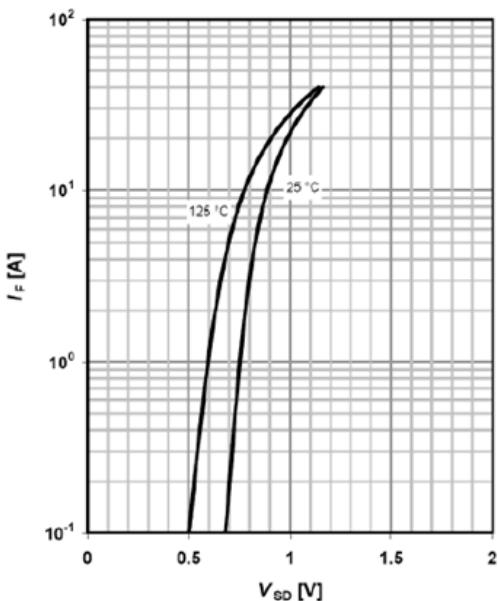


$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$



$$E_{oss} = f(V_{DS})$$

Forward characteristics of reverse diode

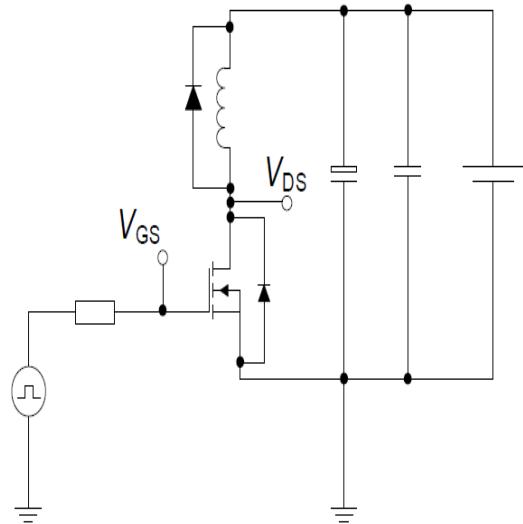


$$I_F = f(V_{SD}); \text{ parameter: } T_j$$

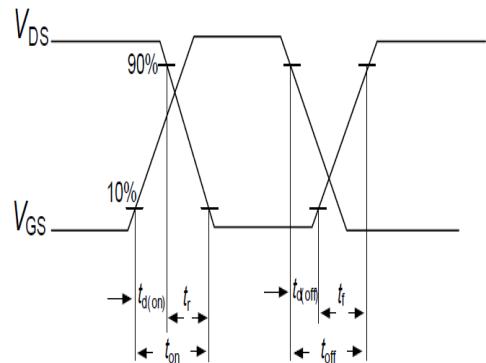
Test circuits

Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load

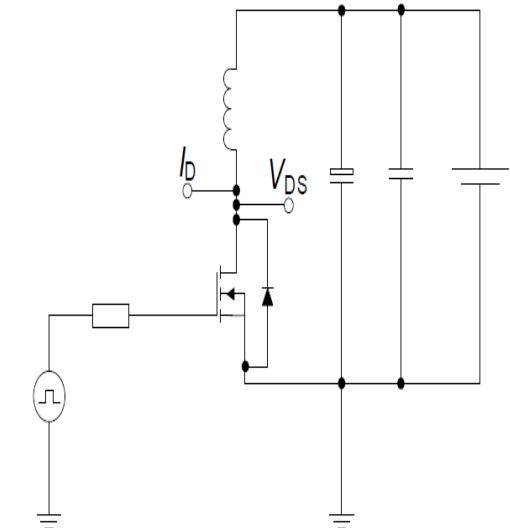


Switching time waveform

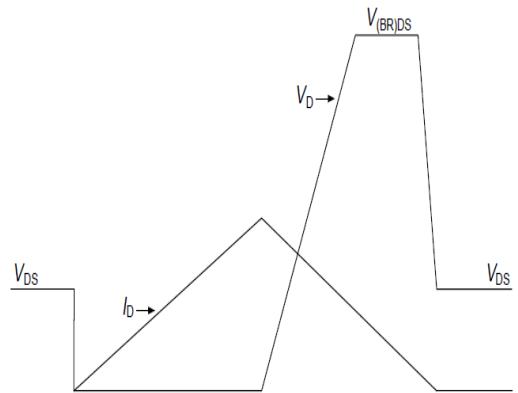


Unclamped inductive load test circuit and waveform

Unclamped inductive load test circuit



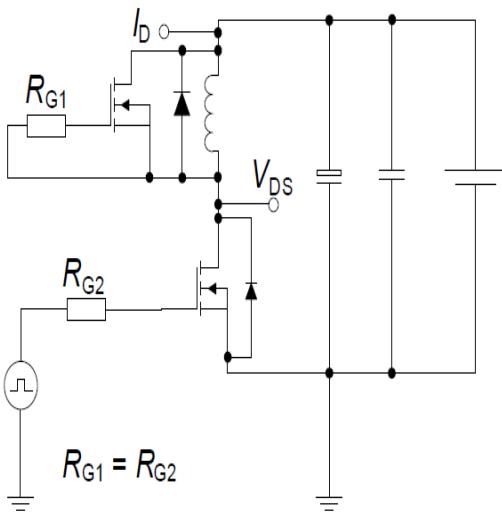
Unclamped inductive waveform



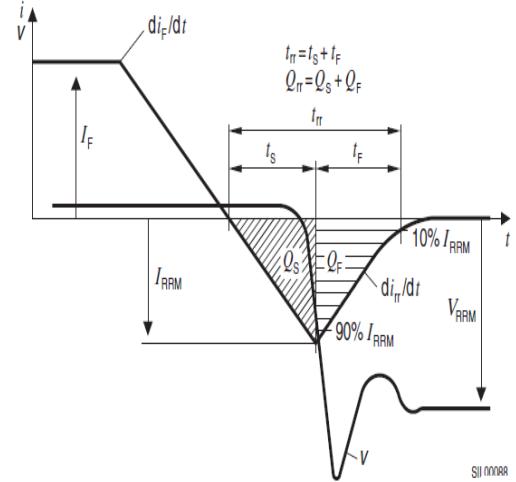
Test circuits

Test circuit and waveform for diode characteristics

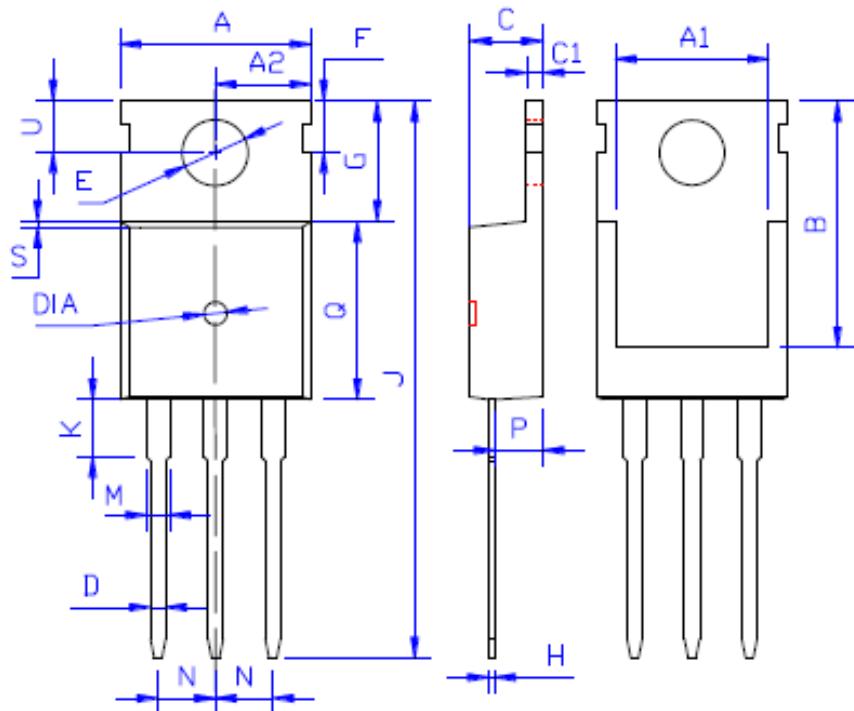
Test circuit for diode characteristics



Diode recovery waveform



Package Outline TO-220



DIM	MILLIMETERS
A	10.00±0.30
A1	8.00±0.30
A2	5.00±0.30
B	13.20±0.40
C	4.50±0.20
C1	1.30±0.20
D	0.80±0.20
E	3.60±0.20
F	3.00±0.30
G	6.60±0.40
H	0.50±0.20
J	28.88±0.50
K	3.00±0.30
M	1.30±0.30
N	Typical 2.54
P	2.40±0.40
Q	9.20±0.40
S	0.25±0.15
T	0.25±0.15
U	2.80±0.30
DIA	宽 1.50±0.10 深 0.50 MAX